



FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE

SHEET <u>1</u> OF <u>1</u>

(REV. 7-80)

MAR 0 5 2001

09/290,608 Center 2001

LIST OF REFERENCES CITED BY APPLICANT

(Use Several Sheets if Necessary)

DOCKET NO.: APPLICANT: 3158/0G015

Tsung-Wei LIN

SERIAL NO:

FILING DATE:

April 1

April 13, 1999

FEB 2 1 2001 W

*EXAMINER INITIALS/

DOCUMENT NUMBER

DATE

NAME

CLASS SUBCLASS

FILING DATE

1. 5,828,380

10/27/98 Lin

FOREIGN PATENT DOCUMENTS

U.S. PATENT DOCUMENTS

*EXAMINER INITIALS DOCUMENT NUMBER

DATE

COUNTRY

CLASS SUBCLASS

TRANSLATION

YES NO

OTHER REFERENCES (INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)

*EXAMINER INITIALS

EXAMINER:

Clubble

DATE CONSIDERED:

6/1/01

*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Docket: 444800.024 Ser. No. 09/302,651 INFORMATION PISCLOSURE CITATION Applicant: Mark E. Eberhardt, Jr. AU6 0 4 1999 Filed: 04-30-99 Group: 2774 TRADEME U.S. PATENT DOCUMENTS Document No. Class Sub Examiner Date Name 5 3 07/96 | Kayser et al. 345/1 3 6 6 04/98 Kayser et al. 345/17 5 3 9 0 05/98 Goodwin, III et al. 235/383 FOREIGN PATENT DOCUMENTS Trans Class Sub Y N Examiner Document No. Date Country OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

* Examiner: Initial if reference considered, whether or not citation is conformance with MPEP 609. Draw line through citation is not in conformance and not considered. Include copy of this form with next communication to applicant.

Date Considered:

h Vo

Examiner: